

**Search Notes**

Application/Control No.

10/693,625

Examiner

DANH C. LE

Applicant(s)/Patent under  
Reexamination

LOCASCIO ET AL.

Art Unit

2683

**SEARCHED**

Class	Subclass	Date	Examiner
455	560	12/19/05	DCL
	561		
	418		
370	442		
	362		
379	202.01		
	201.03		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Interference Search		12/19/20	DCL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search (for double patent check)	12/19/05	DCL
EAST Search updated (USP, USPOB, EPO, JPO DERWENT)		
Lee Nguyen (455)		
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